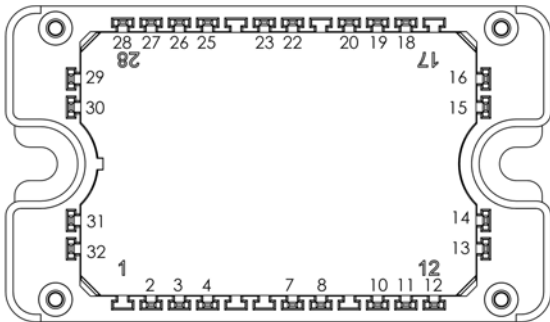
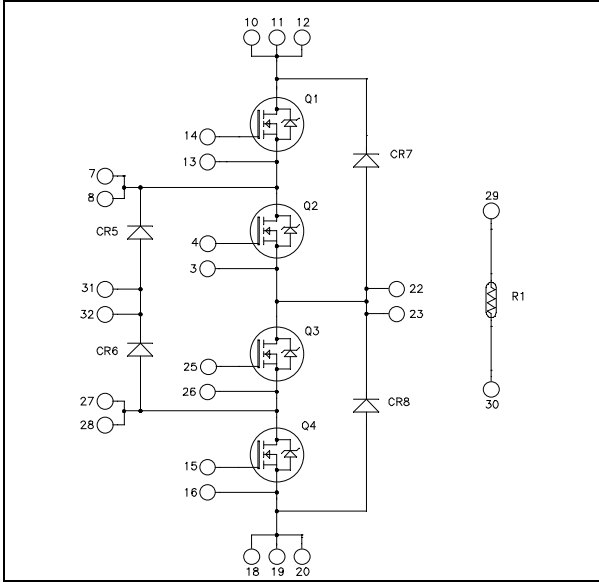


Three level inverter
SiC MOSFET Power Module

SiC Power MOSFET :
 $V_{DSS} = 1200V$; $R_{DS(on)} = 40m\Omega$ @ $T_j = 25^\circ C$



All multiple inputs and outputs must be shorted together
 10/11/12 ; 7/8 ; 27/28 ; ...

All ratings @ $T_j = 25^\circ C$ unless otherwise specified

Q1 to Q4 Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter	Max ratings	Unit
V_{DSS}	Drain - Source Breakdown Voltage	1200	V
I_D	Continuous Drain Current	$T_c = 25^\circ C$	48
		$T_c = 80^\circ C$	38
I_{DM}	Pulsed Drain current	100	A
V_{GS}	Gate - Source Voltage	-6/+23	V
V_{GSOP}	Gate - Source Voltage, recommended operation values	-5/18	V
R_{DSon}	Drain - Source ON Resistance	52	m Ω
P_D	Power Dissipation	$T_c = 25^\circ C$ 263	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Application

- Uninterruptible Power Supplies

Features

- **SiC Power MOSFET**
 - Low $R_{DS(on)}$
 - High temperature performance
- **SiC Schottky Diode**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring
- AlN substrate for improved thermal performance

Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

Q1 to Q4 Electrical Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V ; V_{DS} = 1200V$		10	100	μA
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 20V ; I_D = 40A ; T_j = 25^\circ C$		40	52	m Ω
		$V_{GS} = 18V ; I_D = 40A ; T_j = 175^\circ C$		90		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 10mA$	2		4	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = 20V, V_{DS} = 0V$			250	nA

Q1 to Q4 Dynamic Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 1000V$ $f = 1MHz$		1893		pF
C_{oss}	Output Capacitance			150		
C_{rss}	Reverse Transfer Capacitance			10		
Q_g	Total gate Charge	$V_{GS} = -5/20V$ $V_{Bus} = 800V$ $I_D = 40A$		115		nC
Q_{gs}	Gate – Source Charge			28		
Q_{gd}	Gate – Drain Charge			37		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -5/+20V$ $V_{Bus} = 800V$ $I_D = 40A$ $R_L = 20\Omega ; R_G = 25\Omega$		12		ns
T_r	Rise Time			14		
$T_{d(off)}$	Turn-off Delay Time			23		
T_f	Fall Time			18		
E_{on}	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$ $I_D = 40A$ $R_G = 25\Omega$	$T_j = 150^\circ C$		0.9	mJ
E_{off}	Turn off Energy			$T_j = 150^\circ C$		0.5
R_{Gint}	Internal gate resistance			1.8		Ω
R_{thJC}	Junction to Case Thermal Resistance				0.57	$^\circ C/W$

CR5 & CR6 SiC diode ratings and characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
V_{RRM}	Peak Repetitive Reverse Voltage				600	V	
I_{RM}	Reverse Leakage Current	$V_R = 600V$	$T_j = 25^\circ C$		30	180	μA
			$T_j = 175^\circ C$		60	900	
I_F	DC Forward Current			30		A	
V_F	Diode Forward Voltage	$I_F = 30A$	$T_j = 25^\circ C$		1.6	1.8	V
			$T_j = 175^\circ C$		2	2.4	
Q_C	Total Capacitive Charge	$I_F = 30A, V_R = 600V$ $di/dt = 1000A/\mu s$		84		nC	
C	Total Capacitance	$f = 1MHz, V_R = 200V$		195		pF	
		$f = 1MHz, V_R = 400V$		150			
R_{thJC}	Junction to Case Thermal Resistance				0.8	$^\circ C/W$	

CR7 & CR8 SiC diode ratings and characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V _{RRM}	Peak Repetitive Reverse Voltage				1200	V
I _{RM}	Reverse Leakage Current	V _R =1200V	T _j = 25°C	96	600	μA
			T _j = 175°C	168	3000	
I _F	DC Forward Current		T _c = 125°C	30		A
V _F	Diode Forward Voltage	I _F = 30A	T _j = 25°C	1.6	1.8	V
			T _j = 175°C	2.3	3	
Q _C	Total Capacitive Charge	I _F = 30A, V _R = 1200V di/dt = 1500A/μs		240		nC
C	Total Capacitance	f = 1MHz, V _R = 200V		288		pF
		f = 1MHz, V _R = 400V		207		
R _{thJC}	Junction to Case Thermal Resistance				0.50	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

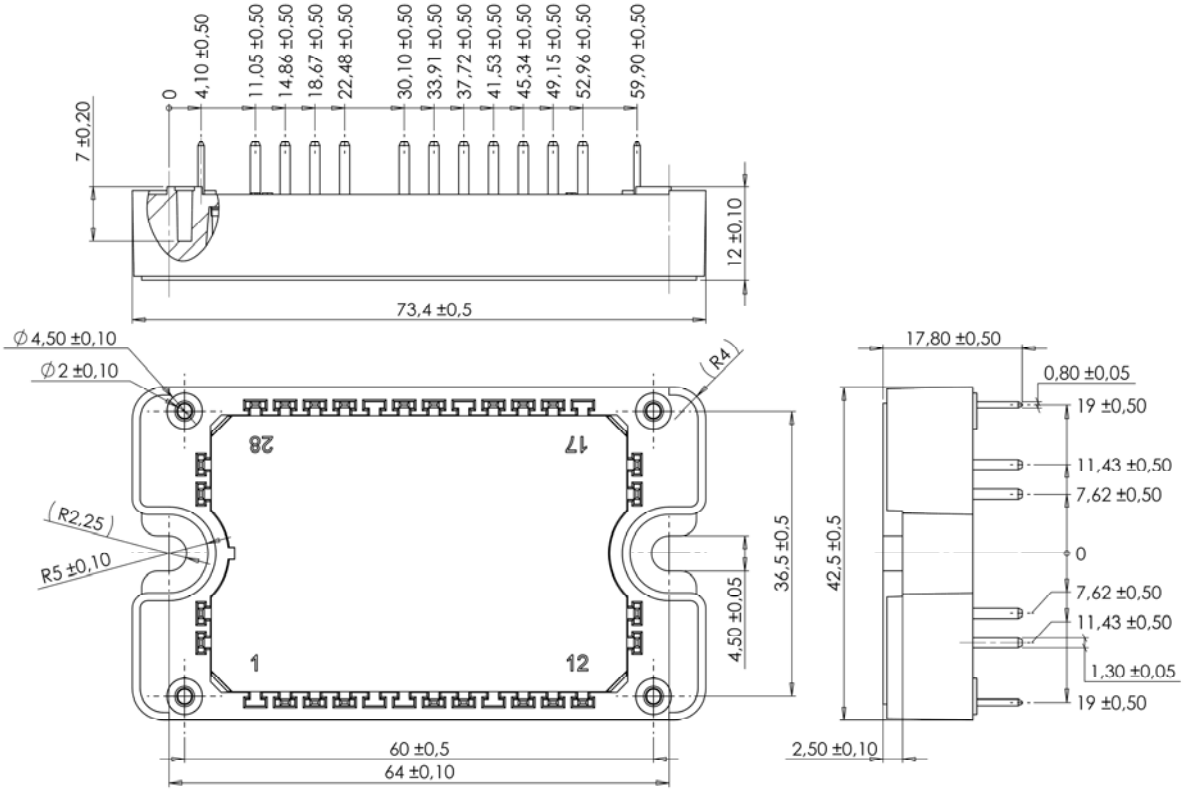
Symbol	Characteristic	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
ΔR ₂₅ /R ₂₅			5		%
B _{25/85}	T ₂₅ = 298.15 K		3952		K
ΔB/B		T _C =100°C	4		%

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature
R_T: Thermistor value at T

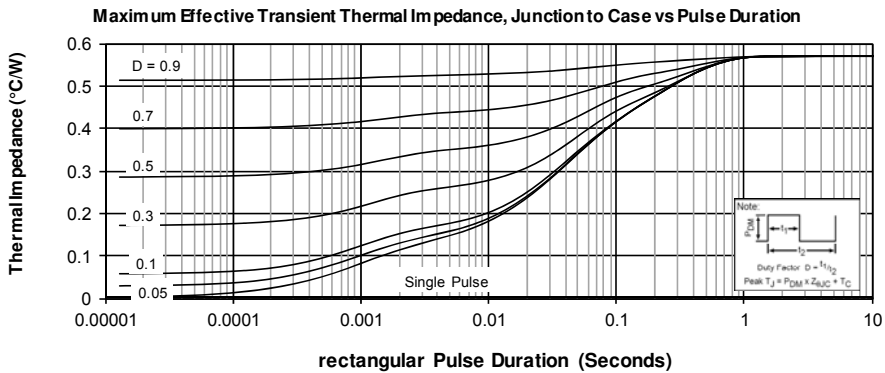
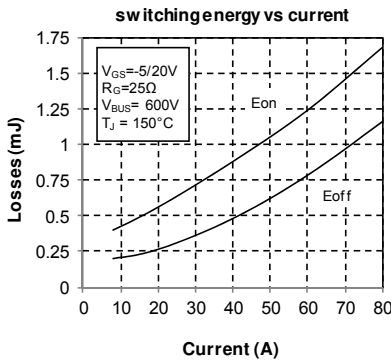
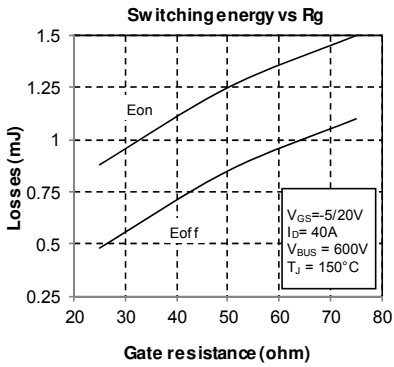
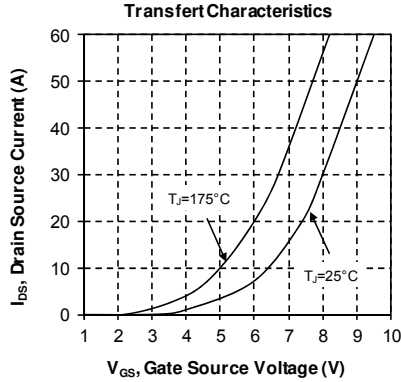
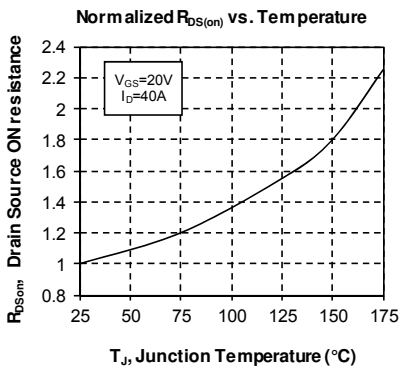
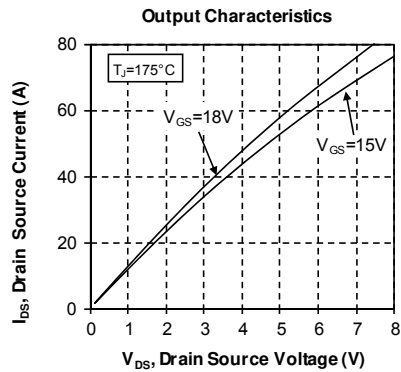
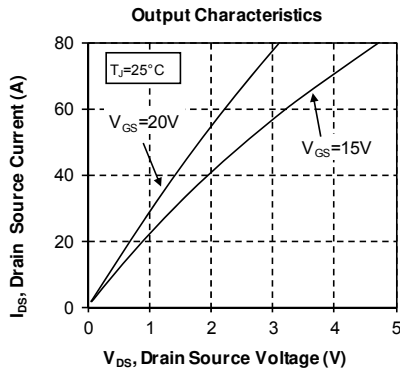
Thermal and package characteristics

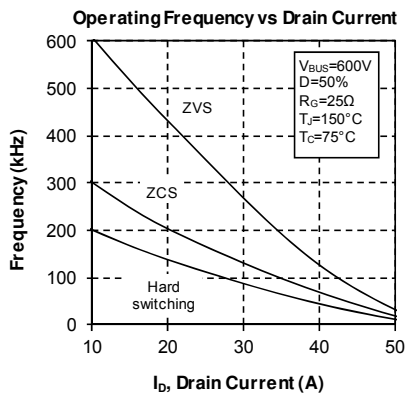
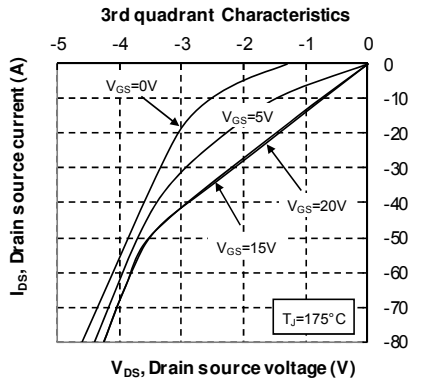
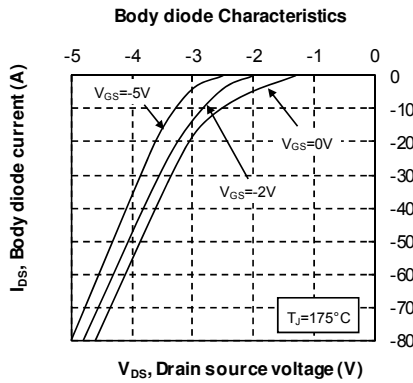
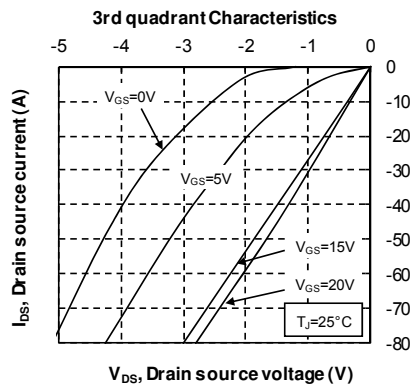
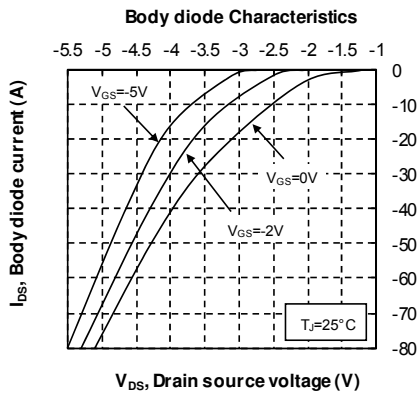
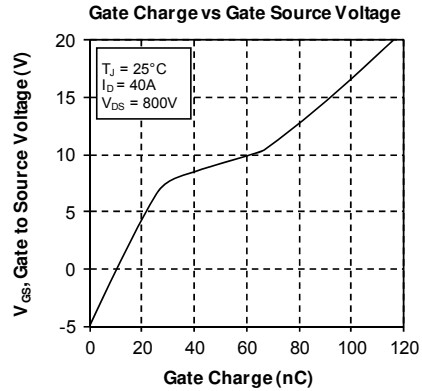
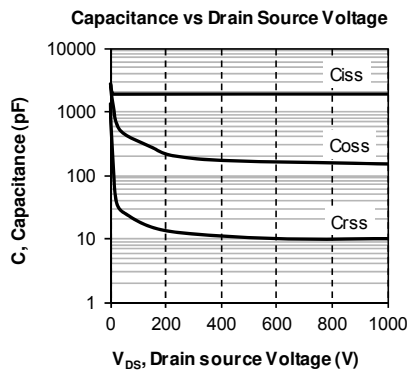
Symbol	Characteristic	Min	Max	Unit		
V _{ISOL}	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000		V		
T _J	Operating junction temperature range	-40	175	°C		
T _{JOP}	Recommended junction temperature under switching conditions	-40	T _{Jmax} -25			
T _{STG}	Storage Temperature Range	-40	125			
T _C	Operating Case Temperature	-40	125			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

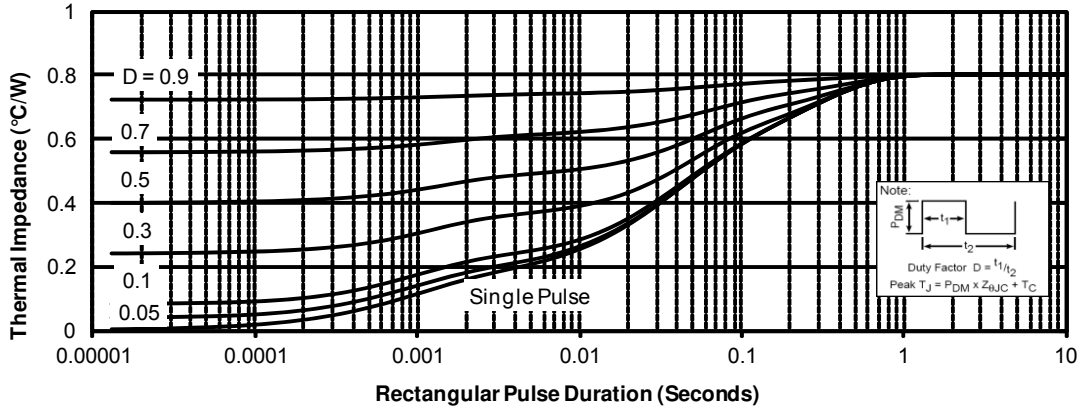
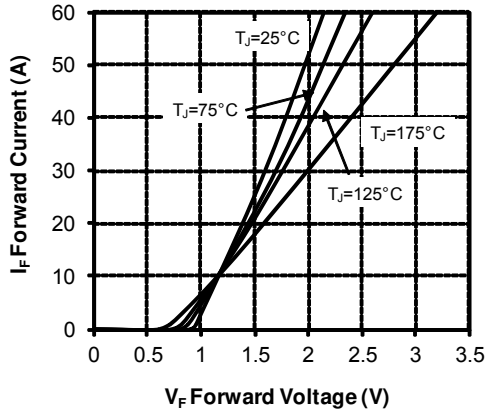
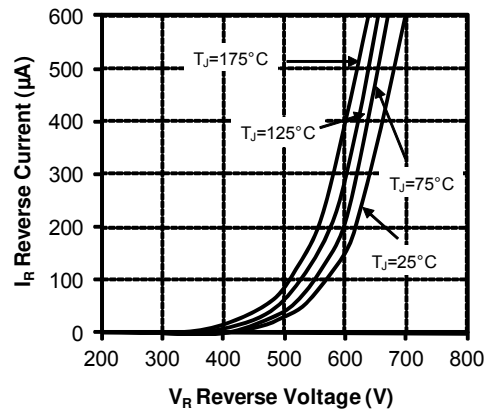
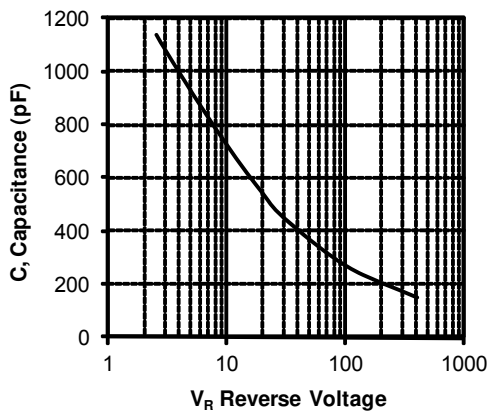
Package outline (dimensions in mm)


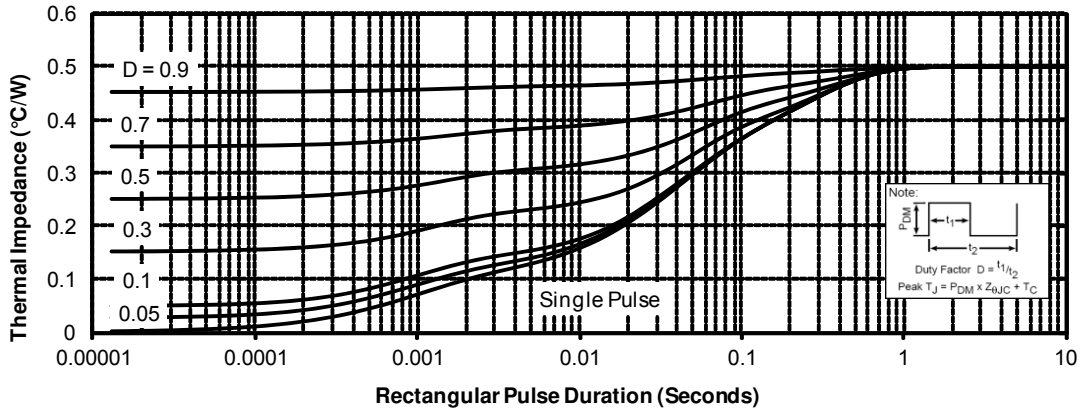
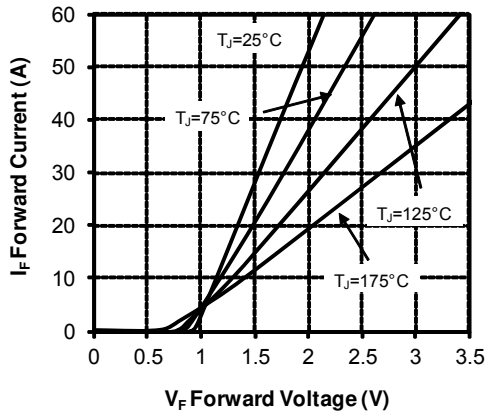
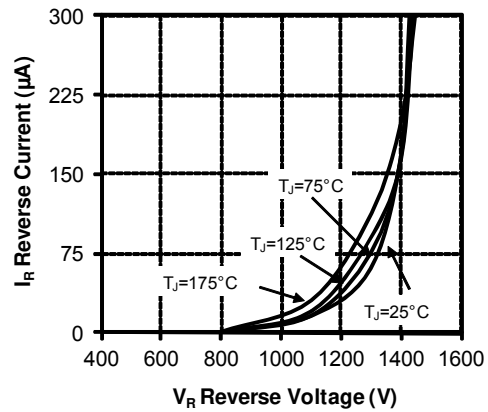
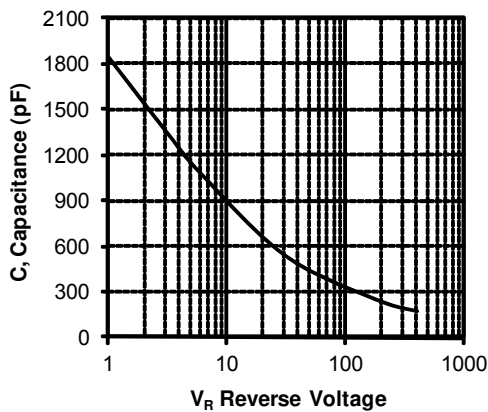
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

Q1 to Q4 Typical performance curve





CR5 & CR6 Typical performance curve
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration

Forward Characteristics

Reverse Characteristics

Capacitance vs. Reverse Voltage


CR7 & CR8 Typical performance curve
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration

Forward Characteristics

Reverse Characteristics

Capacitance vs. Reverse Voltage


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